TOSHIBA 2SC5111FT

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

2 S C 5 1 1 1 F T

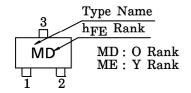
FOR VCO APPLICATION

Unit in mm

MAXIMUM RATINGS (Ta = 25°C)

| CHARACTERISTIC | SYMBOL | RATING | UNIT |
|-----------------------------|--------------------|---------|------|
| Collector-Base Voltage | V_{CBO} | 20 | V |
| Collector-Emitter Voltage | V_{CEO} | 10 | V |
| Emitter-Base Voltage | $V_{ m EBO}$ | 3 | V |
| Base Current | I_{B} | 30 | mA |
| Collector Current | $I_{\mathbf{C}}$ | 60 | mA |
| Collector Power Dissipation | PC | 100 | mW |
| Junction Temperature | T_j | 125 | °C |
| Storage Temperature Range | $\mathrm{T_{stg}}$ | -55~125 | °C |

MARKING



1.2 ± 0.05 0.8 ± 0.05 0.32 0.9 ± 0.1 0.45 L 0.45 BASE 2. **EMITTER** TESM COLLECTOR **JEDEC EIAJ** 2-1B1A TOSHIBA

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

| CHARACTERISTIC | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT |
|------------------------------|-----------------------------------|--|----------|------|------|---------|
| Collector Cut-off Current | I_{CBO} | $V_{CB} = 10V, I_{E} = 0$ | - | | 0.1 | μ A |
| Emitter Cut-off Current | I_{EBO} | $V_{EB}=1V, I_{C}=0$ | _ | _ | 0.1 | μ A |
| DC Current Gain | hFE (Note 1) | $V_{CE}=5V, I_{C}=5mA$ | 80 | _ | 240 | _ |
| Transition Frequency | $ m f_{T}$ | $V_{CE}=5V, I_{C}=5mA$ | 4 | 6 | _ | GHz |
| Insertion Gain | $ \mathrm{S}_{21\mathrm{e}} ^2$ | $V_{\text{CE}} = 5V$, $I_{\text{C}} = 5\text{mA}$, $f = 1\text{GHz}$ | 7 | 11 | _ | dB |
| Output Capacitance | $C_{\mathbf{ob}}$ | $V_{CB} = 5V, I_{E} = 0, f = 1MHz$ | _ | 0.7 | _ | pF |
| Reverse Transfer Capacitance | $\mathrm{C_{re}}$ | (Note 2) | _ | 0.5 | 0.9 | pF |
| Collector-Base Time Constant | C _c ·r _{bb} ' | V_{CB} =5V, I_{C} =3mA, f =30MHz | _ | 5.5 | 10 | ps |

 $O: 80\sim 160, Y: 120\sim 240$ (Note 1): hFE Classification

(Note 2): C_{re} is measured by 3 terminal method with capacitance bridge.

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